

Features

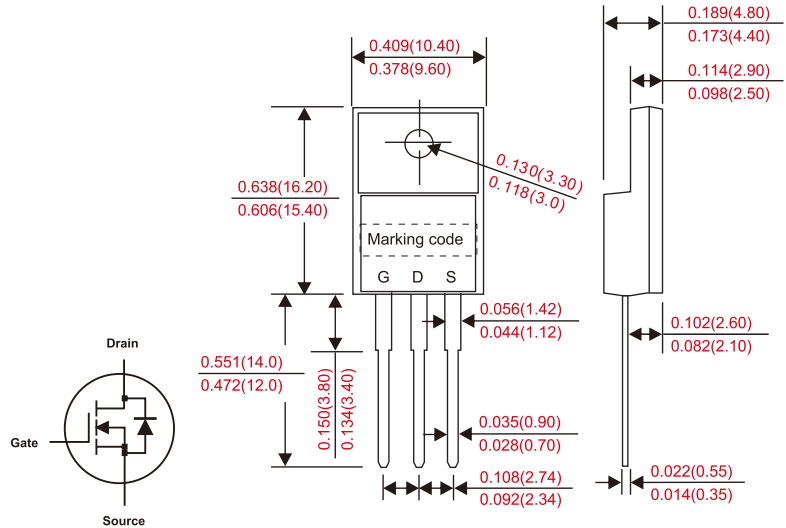
- Fast switching.
- ESD improved capability.
- Low gate charge.
- Low reverse transfer capacitances.
- 100% single pulse avalanche energy test.

Mechanical data

- Epoxy : UL94-V0 rated flame retardant.
- Case : JEDEC TO-220F molded plastic body .
- Terminals : Solder plated, solderable per MIL-STD-750, Method 2026.
- Polarity : As marked.
- Mounting Position : Any .
- Weight : Approximated 2.25 gram .

Outline

TO-220F



Absolute (T_c = 25°C unless otherwise specified)

PARAMETER	CONDITIONS	Symbol	MHF03N80CT	UNIT
Drain-Source Voltage		V _{DSS}	800	V
Continuous Drain Current		I _D	3	A
Continuous Drain Current	T _c = 100 °C		1.9	
Pulsed Drain Current(1)		I _{DM}	12	
Gate-Source Voltage		V _{GS}	±30	V
Single Pulse Avalanche Energy(2)		E _{AS}	120	mJ
Avalanche Current(1)		I _{AR}	1.5	A
Repetitive Avalanche Energy(1)		E _{AR}	12	mJ
Power Dissipation		P _D	30	W
	Derating factor above 25 °C		0.24	W/°C
Peak Diode Recovery dv/dt(3)		dV/dt	5.0	V/ns
Operating and Storage Temperature Range		T _J T _{STG}	-55 ~ +150	°C
Maximum temperature for soldering		T _L	300	°C

NOTE : 1.Repetitive rating; pulse width limited by maximum junction temperature.
 2.L=10.0mH, I_o = 4.9A, Start T_F 25 °C.
 3.I_{SD} =3A, di/dt ≤100A/us, V_{DD} ≤BV_{DS}, Start T_F 25 °C.

■Electrical characteristics(T _c = 25°C unless otherwise specified)						
PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250μA	V _{DSS}	800			V
Bvdss Temperature Coefficient	I _D = 250uA, Reference 25 °C	BV _{DSS} / T _J		0.61		V/°C
Drain-Source Leakage Current	V _{DS} = 800V, V _{GS} = 0V, T _a = 25°C	I _{DSS}			25	uA
	V _{DS} = 640V, V _{GS} = 0V, T _a = 125°C				250	
Gate-Source Leakage Current, Forward	V _{GS} = 30V	I _{GSS(F)}			100	nA
Gate-Source Leakage Current, Reverse	V _{GS} = -30V	I _{GSS(R)}			-100	
■ON Characteristics						
PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	V _{GS(th)}	2.0		4.0	V
Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 1.5A	R _{DS(on)}		4.0	4.8	Ω
■Dynamic Characteristics						
PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Forward Transconductance	V _{DS} = 15V, I _D = 1.5A	g _{fs}		5.5		S
Input Capacitance	V _{DS} = 25V, V _{GS} = 0V, f = 1.0MHz	C _{iss}		660		pF
Output Capacitance		C _{oss}		50		
Reverse Transfer Capacitance		C _{rss}		7		
■Resistive Switching Characteristics						
PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Turn-on Delay Time	I _D = 3A, V _{DD} = 400V, V _{GS} = 10V, R _G = 12Ω	td _(ON)		16		ns
Rise Time		tr		15		
Turn-off Delay Time		td _(OFF)		40		
Fail Time		tf		20		
Total Gate Charge	I _D = 3A, V _{DD} = 400V, V _{GS} = 10V	Q _g		18		nC
Gate-Source Charge		Q _{gs}		5		
Gate-Drain Charge		Q _{gd}		8		
■Source-Drain Diode Characteristics						
PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Continuous Source-Drain Diode Current	Body Diode	I _S			3	A
Pulse Diode Forward Current	Body Diode	I _{SM}			12	
Body Diode Voltage	I _S = 3.0A, V _{GS} = 0V	V _{SD}			1.5	V
Reverse recovery time	I _S = 3A, T _J = 25 °C, di _F /dt = 100A/μs, V _{GS} = 0V	t _{rr}		820		ns
Reverse recovery charge		Q _{rr}			6.05	
■Thermal characteristics						
PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Thermal Resistance	Junction to Case	R _{BJC}		4.17		°C/W
	Junction to Ambient	R _{BJA}		100		

■ Rating and characteristic curves

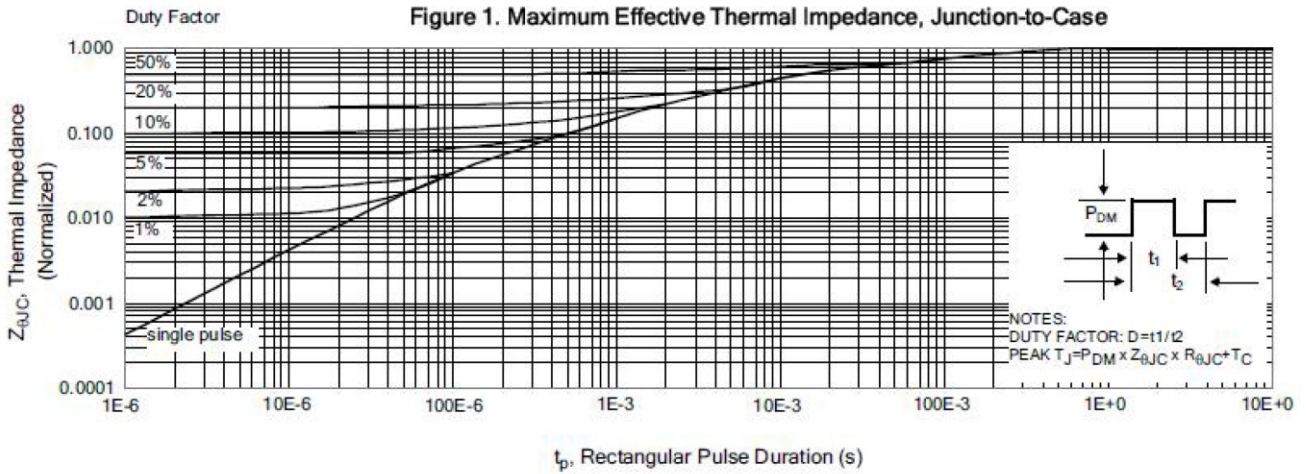


Figure 2. Maximum Power Dissipation vs Case Temperature

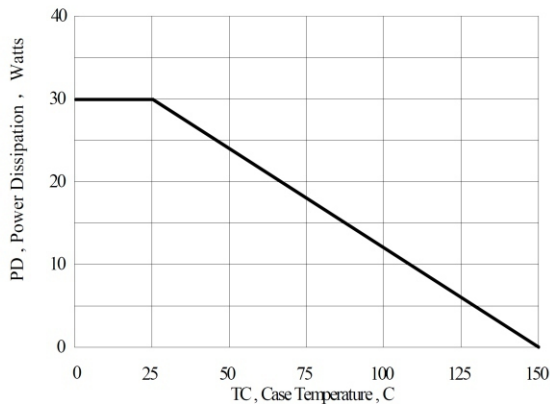


Figure 3. Maximum Continuous Drain Current vs Case Temperature

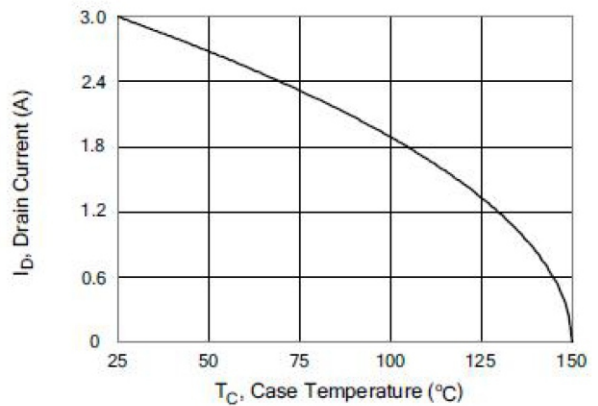


Figure 4. Typical Output Characteristics

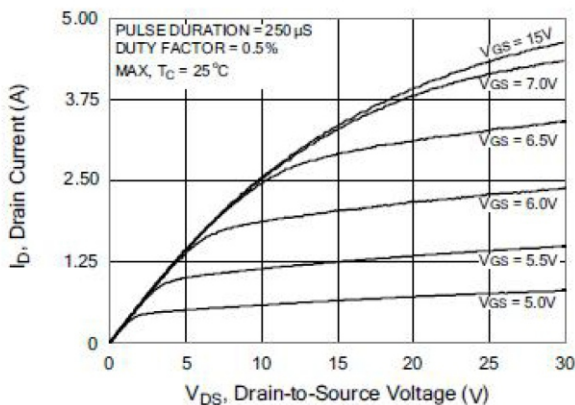
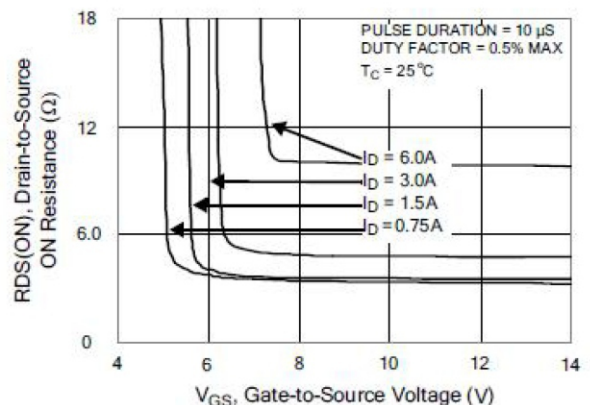


Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current



Rating and characteristic curves

Figure 6. Maximum Peak Current Capability

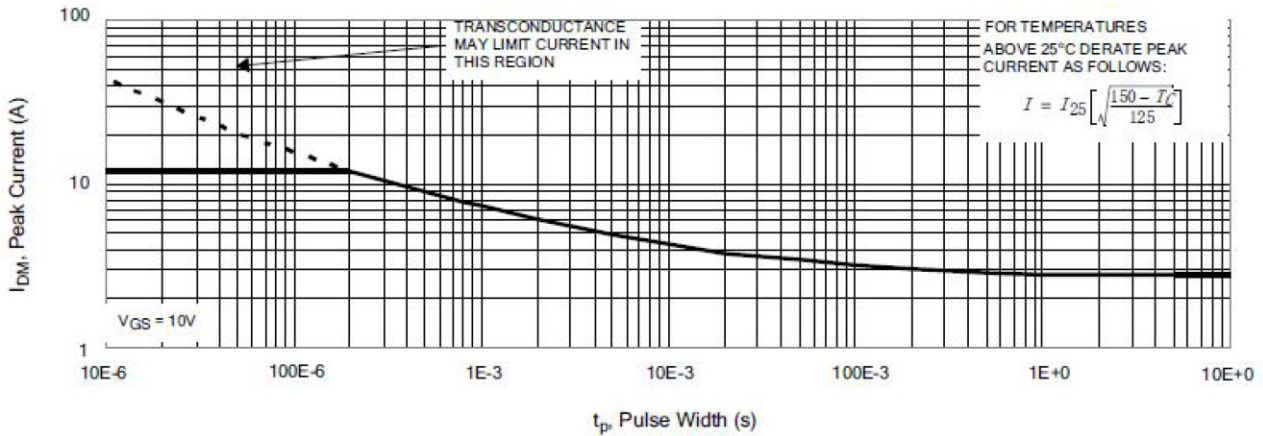


Figure 7. Typical Transfer Characteristics

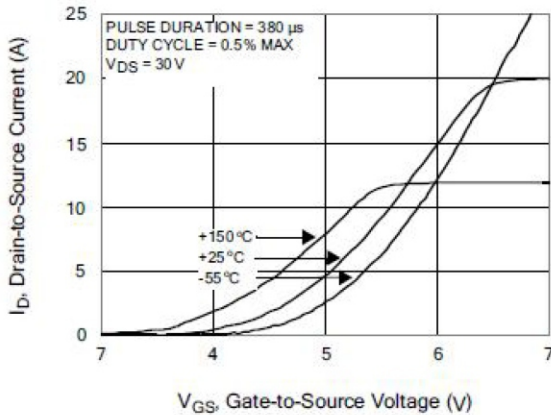


Figure 8. Unclamped Inductive Switching Capability

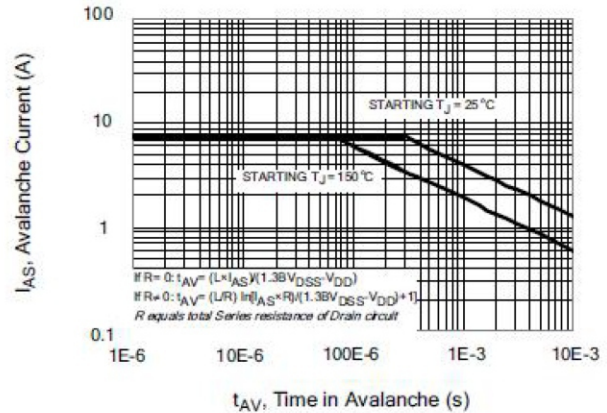


Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current

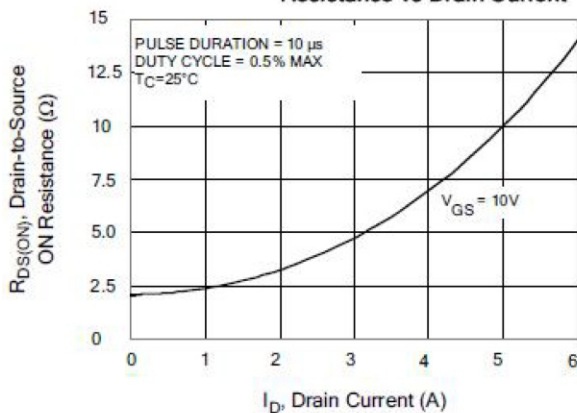
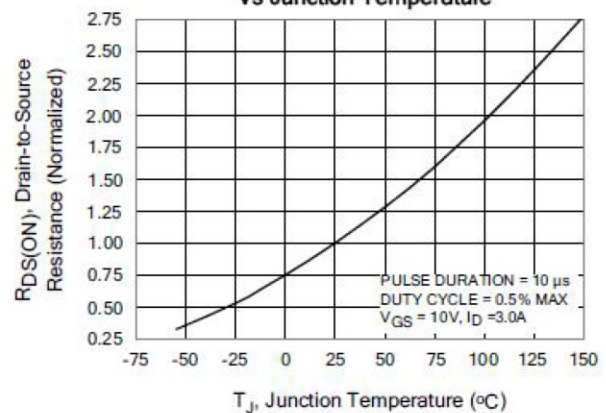


Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature



Rating and characteristic curves

Figure 11. Typical Breakdown Voltage vs Junction Temperature

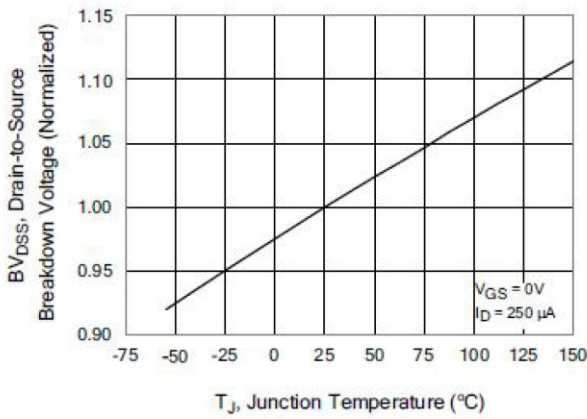


Figure 12. Typical Threshold Voltage vs Junction Temperature

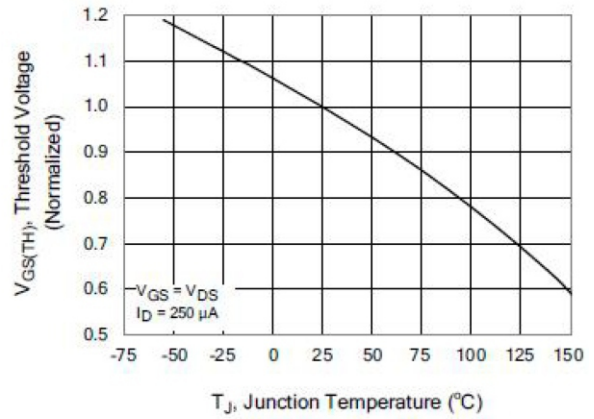


Figure 13. Maximum Forward Bias Safe Operating Area

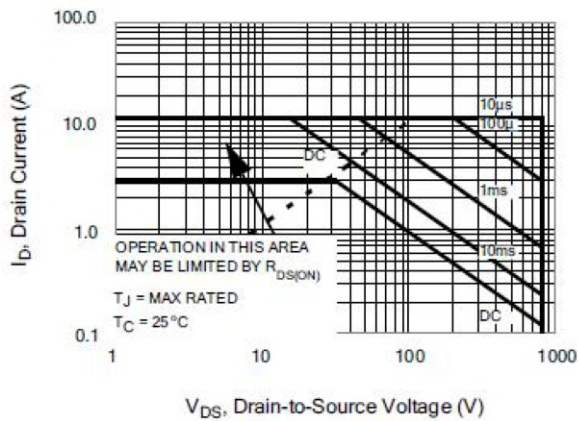


Figure 14. Typical Capacitance vs Drain-to-Source Voltage

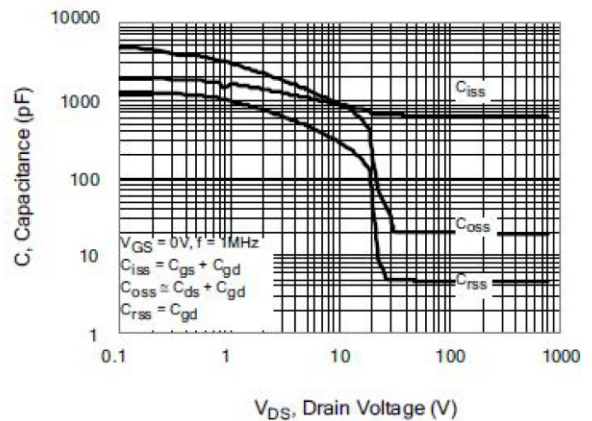


Figure 15. Typical Gate Charge vs Gate-to-Source Voltage

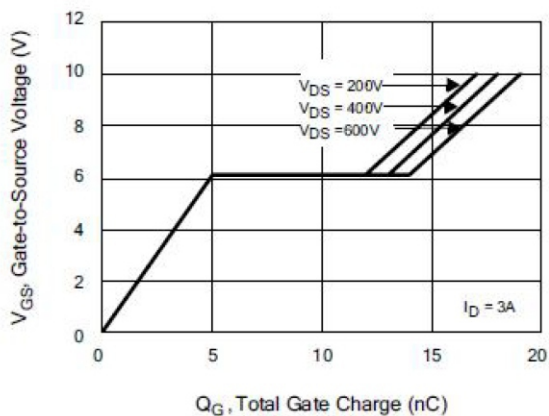
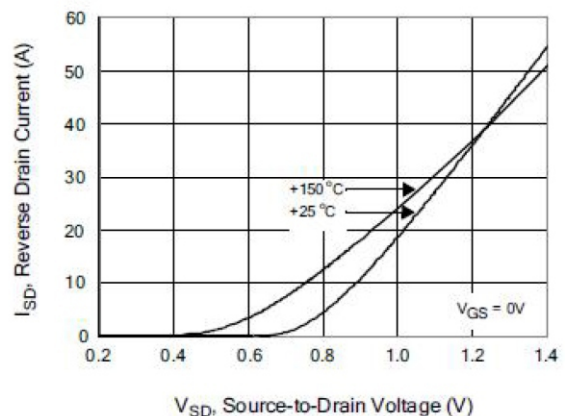


Figure 16. Typical Body Diode Transfer Characteristics



■ Test circuit and waveform

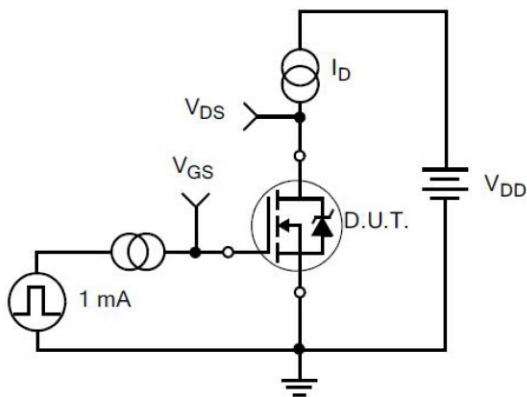


Figure 17. Gate Charge Test Circuit

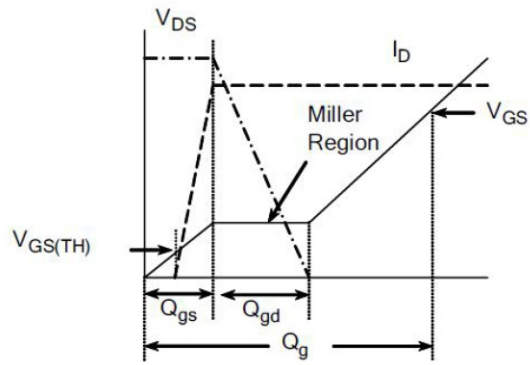


Figure 18. Gate Charge Waveform

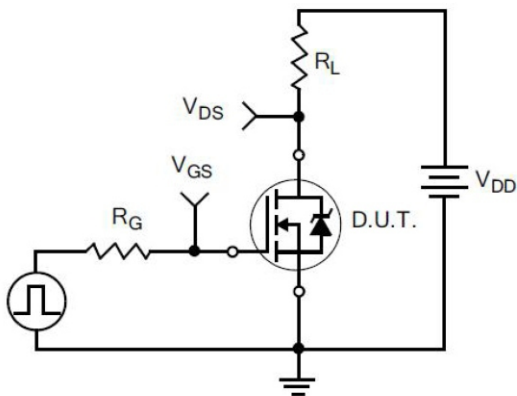


Figure 19. Resistive Switching Test Circuit

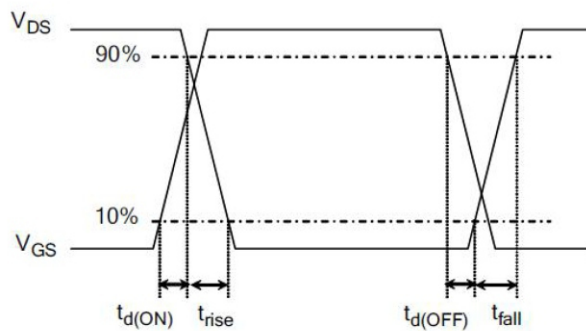


Figure 20. Resistive Switching Waveforms

■ Test circuit and waveform

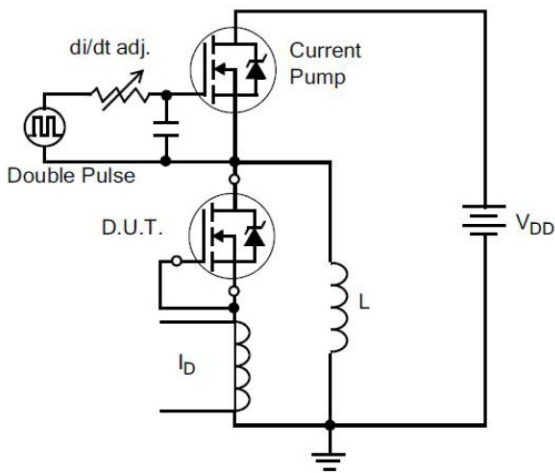


Figure 21. Diode Reverse Recovery Test Circuit

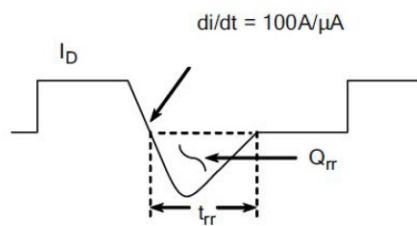


Figure 22. Diode Reverse Recovery Waveform

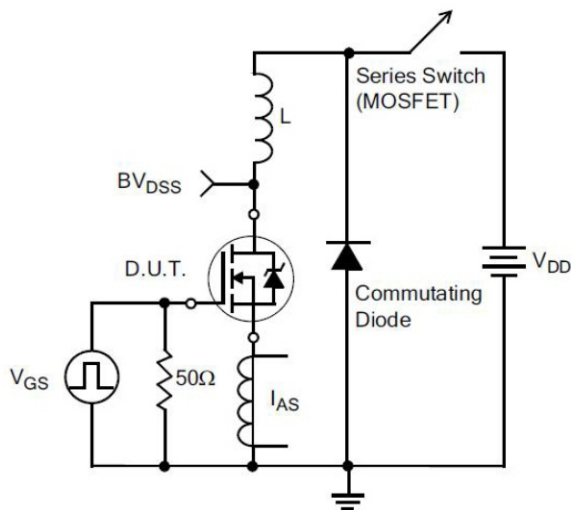


Figure 23. Unclamped Inductive Switching Test Circuit

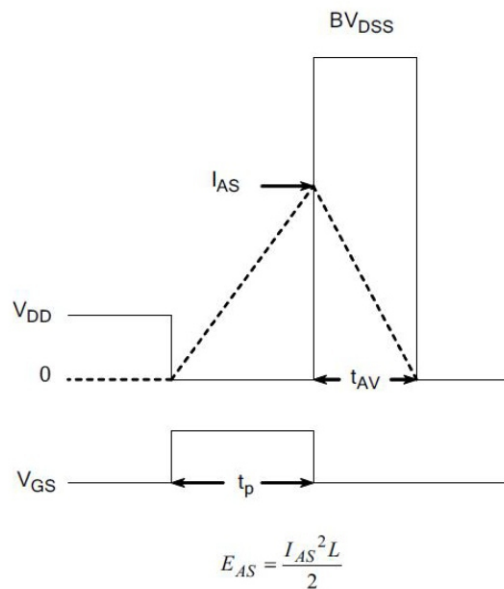


Figure 24. Unclamped Inductive Switching Waveforms

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